

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/621,348	YASUDA, SUSUMU
	Examiner	Art Unit
	James Phan	2872

SEARCHED			
Class	Subclass	Date	Examiner
359	198- 199	2/05	J.P.-
	223		
	224		
	290		
	291		
	298		
310	309		
	311		
	272		
	40mm		
<u>Updated</u>		6/05	J.P.-

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner